Se	arc	h.	No	otes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/072,683	ZUK ET AL.
Examiner	Art Unit
Minh Dieu Nguyen	2137

SEARCHED				
Class	Subclass	Date	Examiner	
726	11-13, 22- 25	3/21/2007	MDN	
709	238-244	3/21/2007	MDN	
713	153, 189	3/21/2007	MDN	
705	51, 54	3/21/2007	MDN	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		-			
	<u></u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	3/21/2007	MDN	
Updated text and class search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	3/21/2007	MDN	
Every claim has been reviewed for 35 USC non-statutory subject matter	3/21/2007	MDN	
Consulted w/ T. Arani on areas of search	3/21/2007	MDN	
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